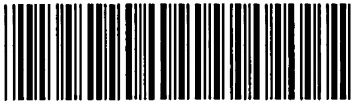


Search Notes

Application/Control No.

10/565,829

Examiner

Jennifer Y. Cho

Applicant(s)/Patent under
Reexamination

KIM ET AL.

Art Unit

1621

SEARCHED

Class	Subclass	Date	Examiner
435	280	2/22/2007	JC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	2/22/2007	JC
STN	2/2/2007	BO
STN	2/22/2007	KS